

Notic of References Cit d

Application/Control N

09/734,176

Applicant(s)/Patent Under
Reexamination
MIKAWA ET AL.

Examiner

Steven Loke

Art Unit

2811

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,225,185	05-2001	Yamazaki et al.	438/396
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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